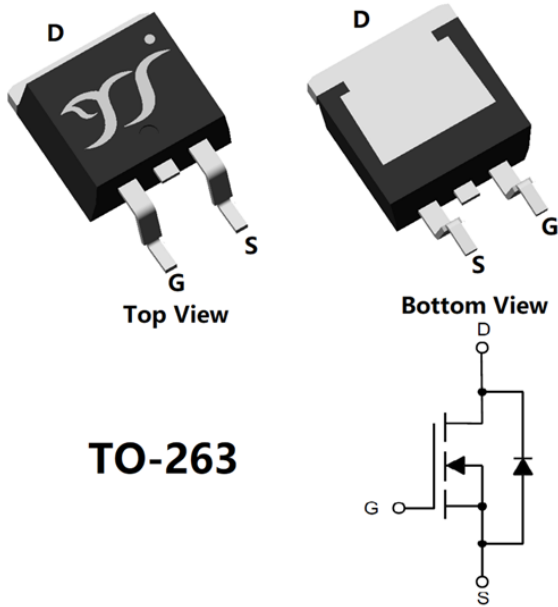


N-Channel Enhancement Mode Field Effect Transistor



TO-263

Product Summary

• V_{DS}	650V
• I_D	16.5A
• $R_{DS(ON)}$ (at $V_{GS}=10V$)	<190mΩ
• 100% EAS Tested	
• 100% ∇V_{DS} Tested	

General Description

- Super Junction High Voltage MOSFET Technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Switching Mode Power Supplies (SMPS)
- PWM Motor Controls
- LED Lighting
- Adapter

Limiting Values

Parameter	Conditions		Symbol	Min	Max	Unit
Drain-source Voltage			V _{DS}	-	650	V
Gate-source Voltage			V _{GS}	-30	30	
Continuous Drain Current (Note 1,2)	Steady-State	T _A =25°C,V _{GS} =10V	I _D	-	2.5	A
		T _A =100°C,V _{GS} =10V		-	1.5	
Continuous Drain Current (Note 1,3)	Steady-State	T _C =25°C,V _{GS} =10V		-	16.5	
		T _C =100°C,V _{GS} =10V		-	10.4	
Pulsed Drain Current	T _C =25°C,t _p ≤10μs		I _{DM}	-	50	
Maximum Body-Diode Continuous Current	T _C =25°C		I _S		16.5	
Maximum Body-Diode Pulsed Current	T _C =25°C,t _p ≤10μs		I _{SM}	-	50	
Avalanche Energy (non-repetitive)	T _J =25°C,V _G =10V,R _G =25Ω,L=30mH,I _{AS} =4.6A		EAS	-	317.4	mJ
Total Power Dissipation (Note 1,2)	Steady-State	T _A =25°C	P _D	-	3.1	W
		T _A =100°C		-	1.2	
Total Power Dissipation (Note 1,3)	Steady-State	T _C =25°C		-	138	
		T _C =100°C		-	55	
MOSFET dv/dt Ruggedness	T _J =25°C,V _{DS} =0...325V,I _D <=15.5A,R _g =0Ω		dv/dt	-	67	V/ns
Reverse Diode dv/dt	T _J =25°C,V _{DS} =0...325V,I _D <=15.5A,di/dt=200A/us		dv/dt	-	116	
Maximum Diode Commutation Speed	T _J =25°C,V _{DS} =0...325V,I _D <=15.5A,R _g =0Ω		dif/dt	-	1540	A/us
Junction and Storage Temperature Range			T _J , T _{STG}	-55	150	°C

Thermal Resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	Steady-State	$R_{\theta JA}$	-	40	$^{\circ}C/W$
Thermal Resistance Junction-to-Case	Steady-State	$R_{\theta JC}$	-	0.9	

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJB190D65CFJ	F2	YJB190D65CF	800	/	8000	13" reel



YJB190D65CFJ

■ Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA, T _j =25°C	650	-	-	V
		V _{GS} =0V, I _D =10mA, T _j =25°C	650	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _j =25°C	-	-	10	μA
		V _{DS} =650V, V _{GS} =0V, T _j =100°C	-	-	100	
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V, T _j =25°C	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA, T _j =25°C	2.7	3.5	4.3	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =10A, T _j =25°C	-	150	190	mΩ
		V _{GS} =10V, I _D =10A, T _j =150°C	-	390	492	mΩ
Diode Forward Voltage	V _{SD}	I _S =10A, V _{GS} =0V, T _j =25°C	-	0.88	1.2	V
Gate Resistance	R _G	f=1MHz, T _j =25°C	-	5	-	Ω
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =325V, V _{GS} =0V, f=1MHz, T _j =25°C	-	1500	-	pF
Output Capacitance	C _{oss}		-	37	-	
Reverse Transfer Capacitance	C _{rss}		-	5	-	
Effective Output capacitance, Energy Related	C _{o(er)}	V _{DS} =0...325V, V _{GS} =0V, f=1MHz, T _j =25°C	-	64	-	
Effective Output Capacitance, Time Related	C _{o(tr)}		-	396	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =325V, I _D =16.5A, T _j =25°C	-	33	-	nC
Gate-Source Charge	Q _{gs}		-	9	-	
Gate-Drain Charge	Q _{gd}		-	14	-	
Reverse Recovery Charge	Q _{rr}	I _F =16.5A, di/dt=100A/μs, V _{GS} =0V, V _R =325V, T _j =25°C	-	933	-	nC
Reverse Recovery Time	t _{rr}		-	133	-	ns
Peak Reverse Recovery Current	I _{rrm}		-	13.5	-	A
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DS} =325V, I _D =16.5A, R _{GEN} =3Ω, T _j =25°C	-	66	-	ns
Turn-on Rise Time	t _r		-	27	-	
Turn-off Delay Time	t _{D(off)}		-	32	-	
Turn-off Fall Time	t _f		-	9.5	-	

Note:

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. The value of $R_{\theta JA}$ is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with $T_A=25^\circ C$. The maximum allowed junction temperature of $150^\circ C$. The value in any given application depends on the user's specific board design.
3. Thermal resistance from junction to soldering point (on the exposed drain pad).



■ Typical Electrical and Thermal Characteristics Diagrams

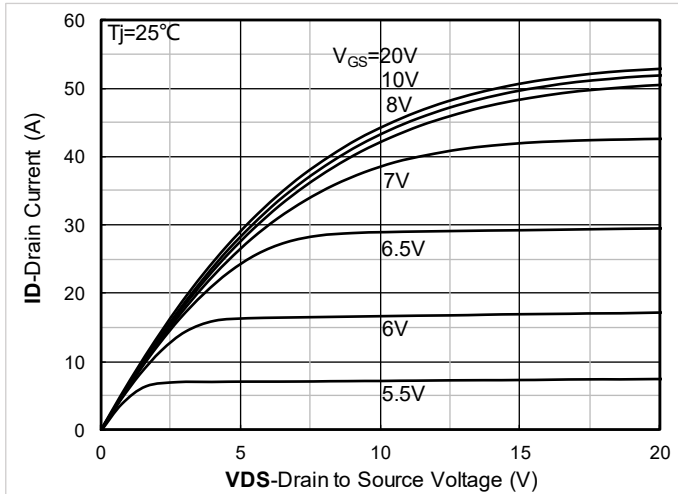


Figure 1. Output Characteristics; typical values

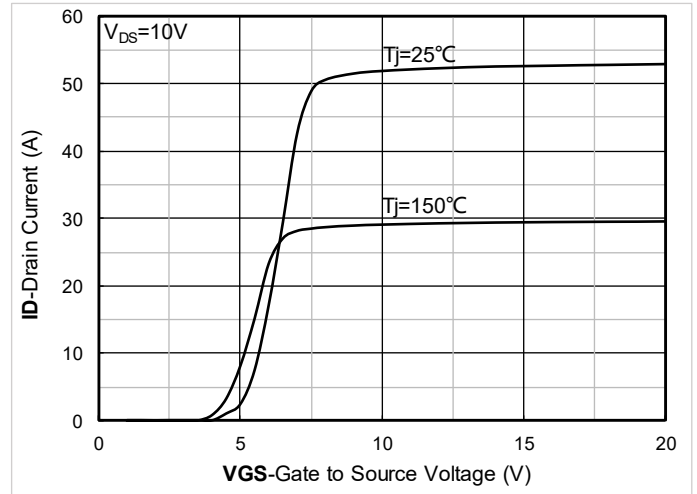


Figure 2. Transfer Characteristics; typical values

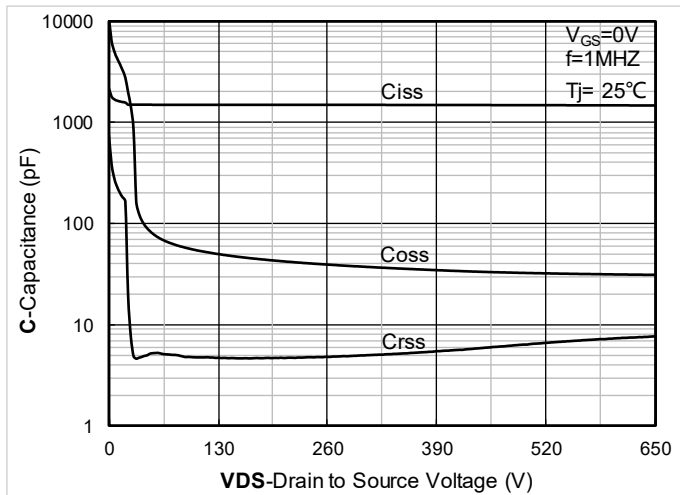


Figure 3. Capacitance Characteristics; typical values

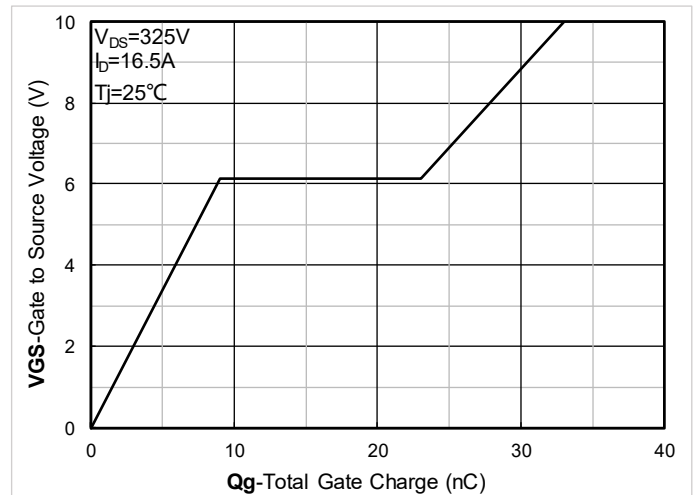


Figure 4. Gate Charge; typical values

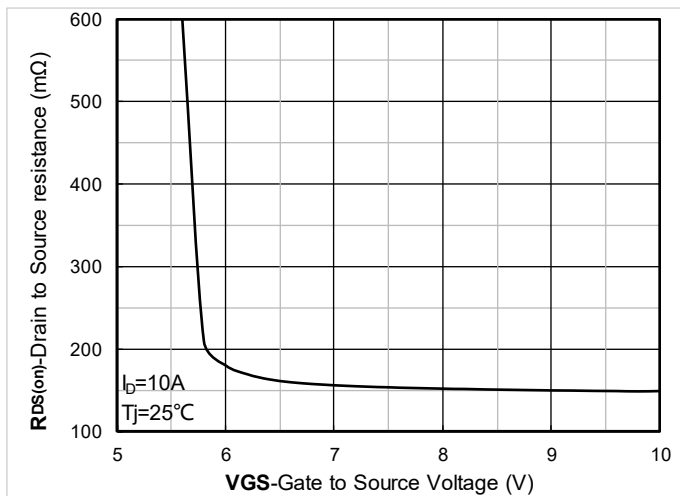


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

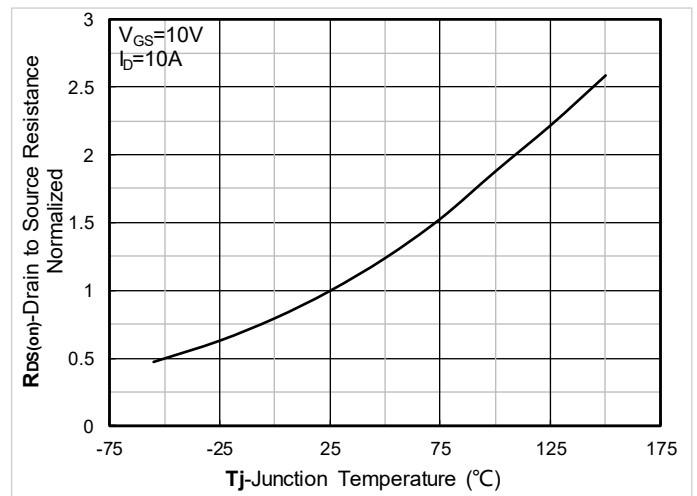


Figure 6. Normalized On-Resistance

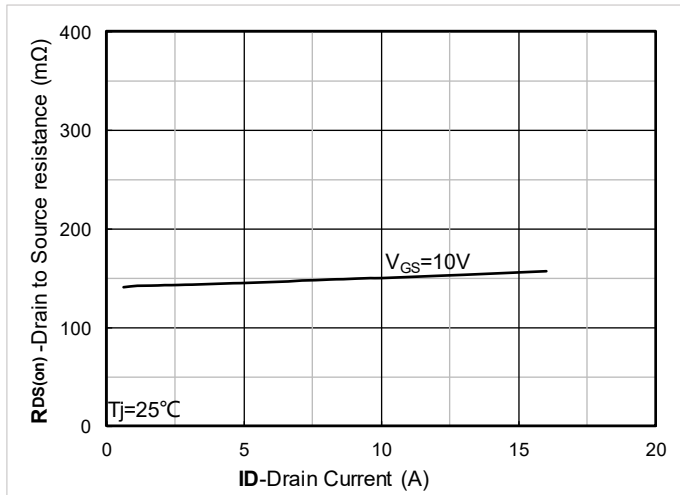


Figure 7. RDS(on) vs. Drain Current; typical values

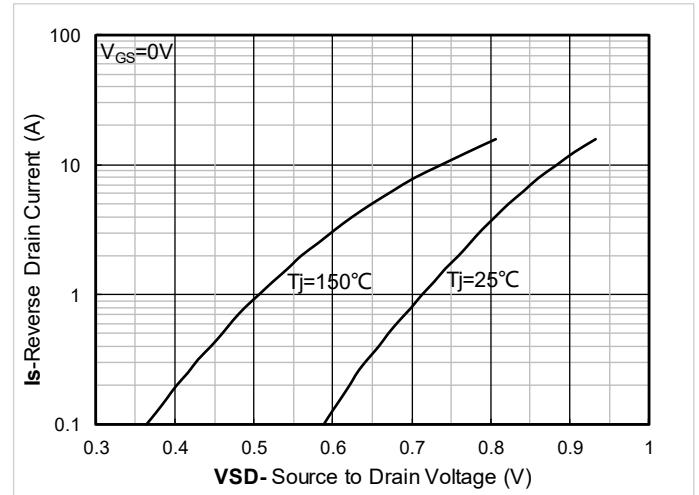


Figure 8. Forward characteristics of reverse diode; typical values

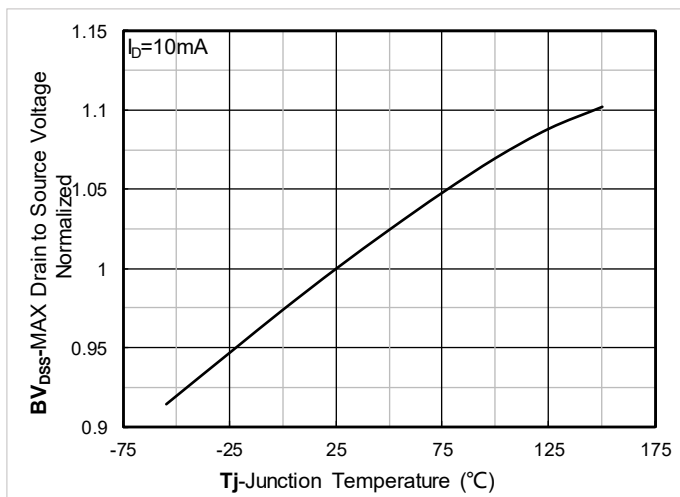


Figure 9. Normalized breakdown voltage

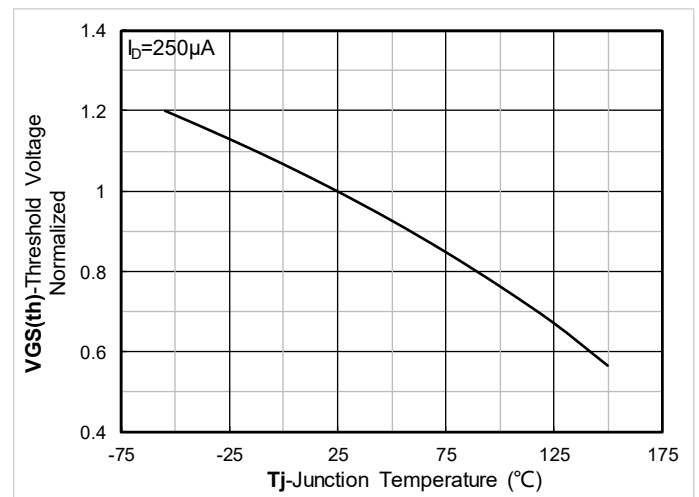


Figure 10. Normalized Threshold voltage

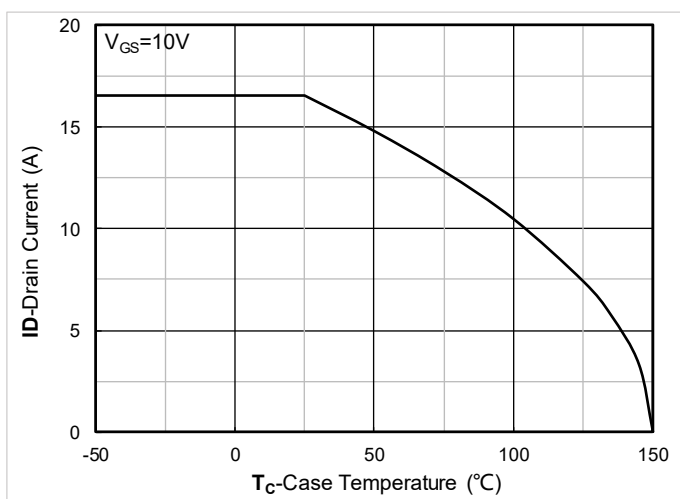


Figure 11. Current dissipation

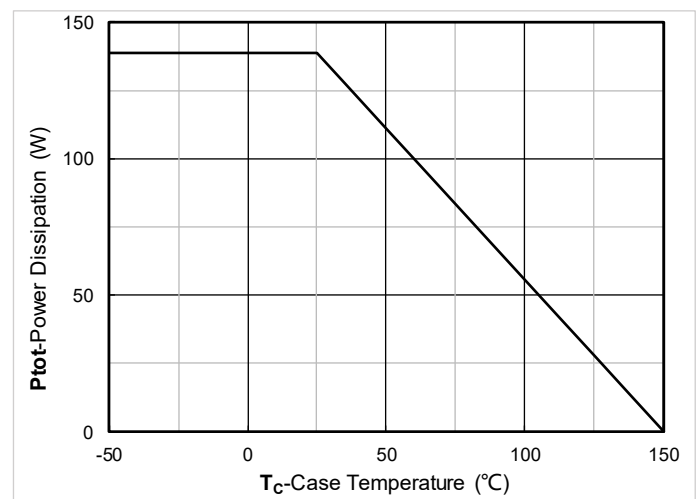


Figure 12. Power dissipation

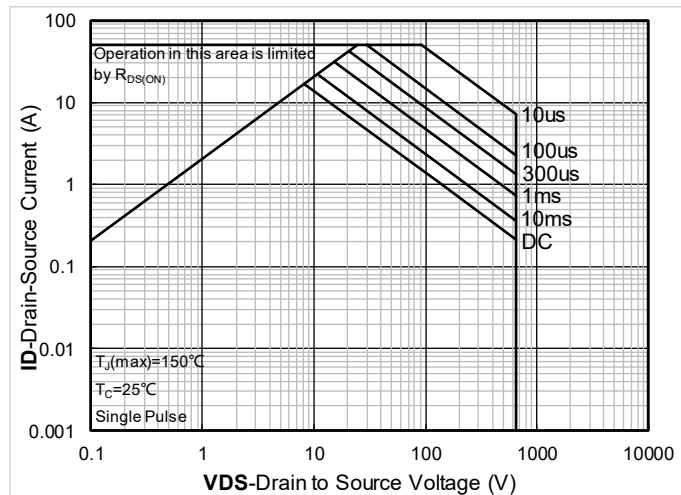


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

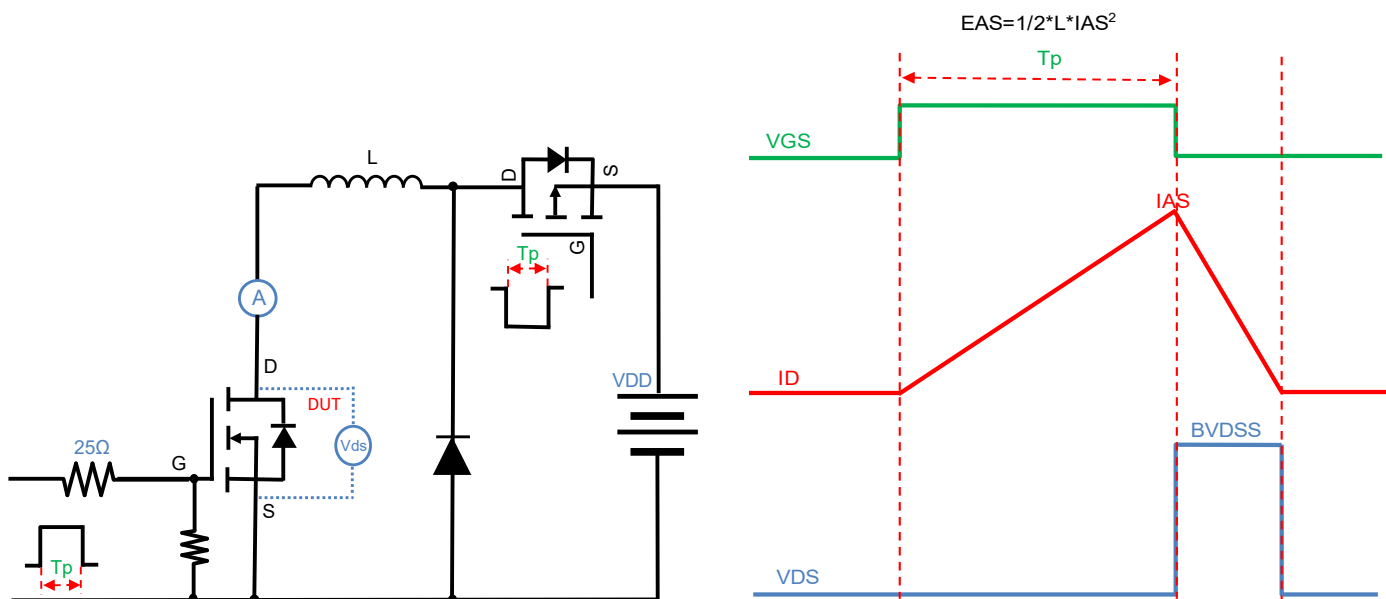


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

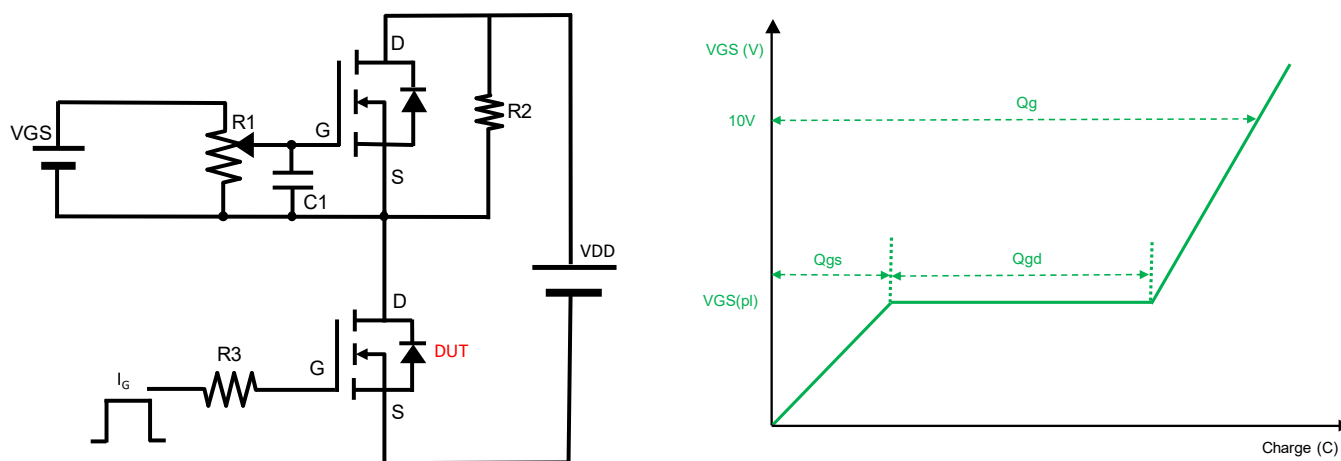


Figure B. Gate Charge Test Circuit & Waveform

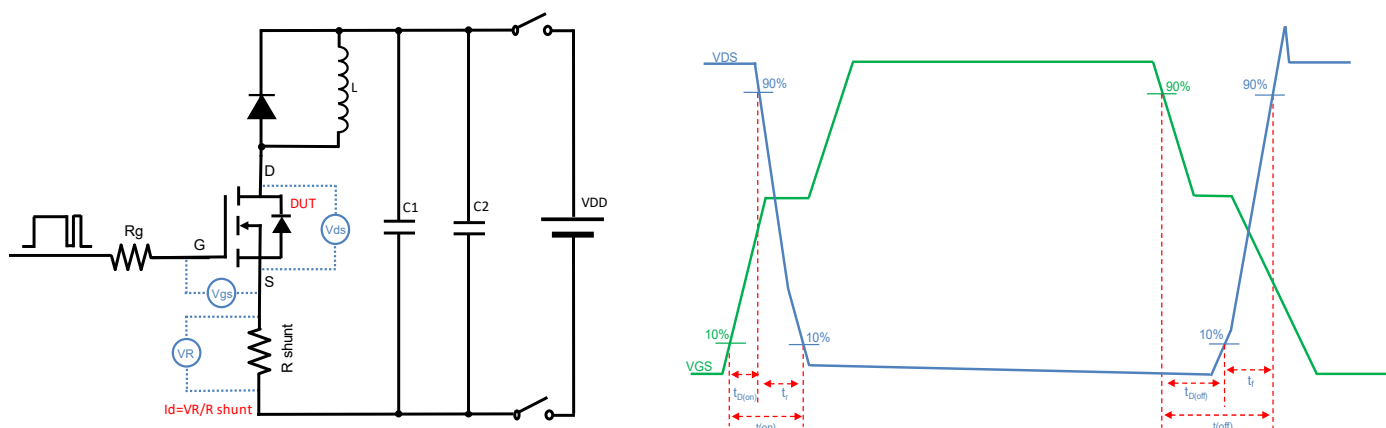


Figure C. Resistive Switching Test Circuit & Waveform

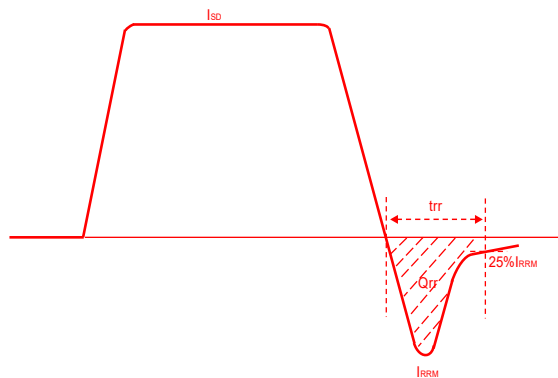
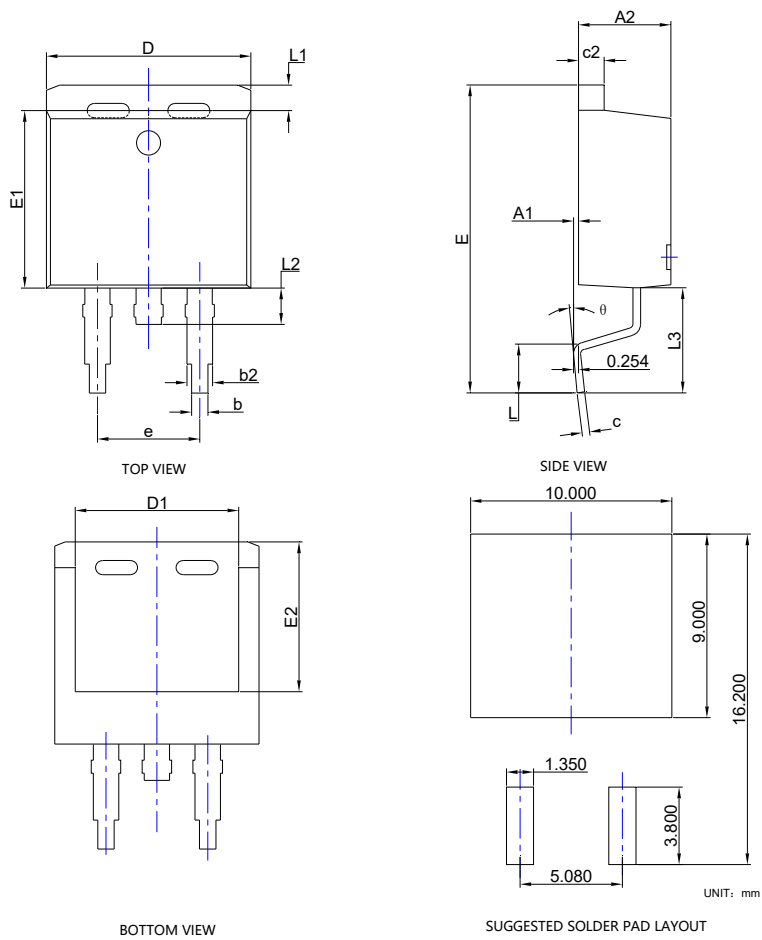


Figure D. Diode Recovery Test Circuit & Waveform



YJB190D65CFJ

■ TO-263-B Package information



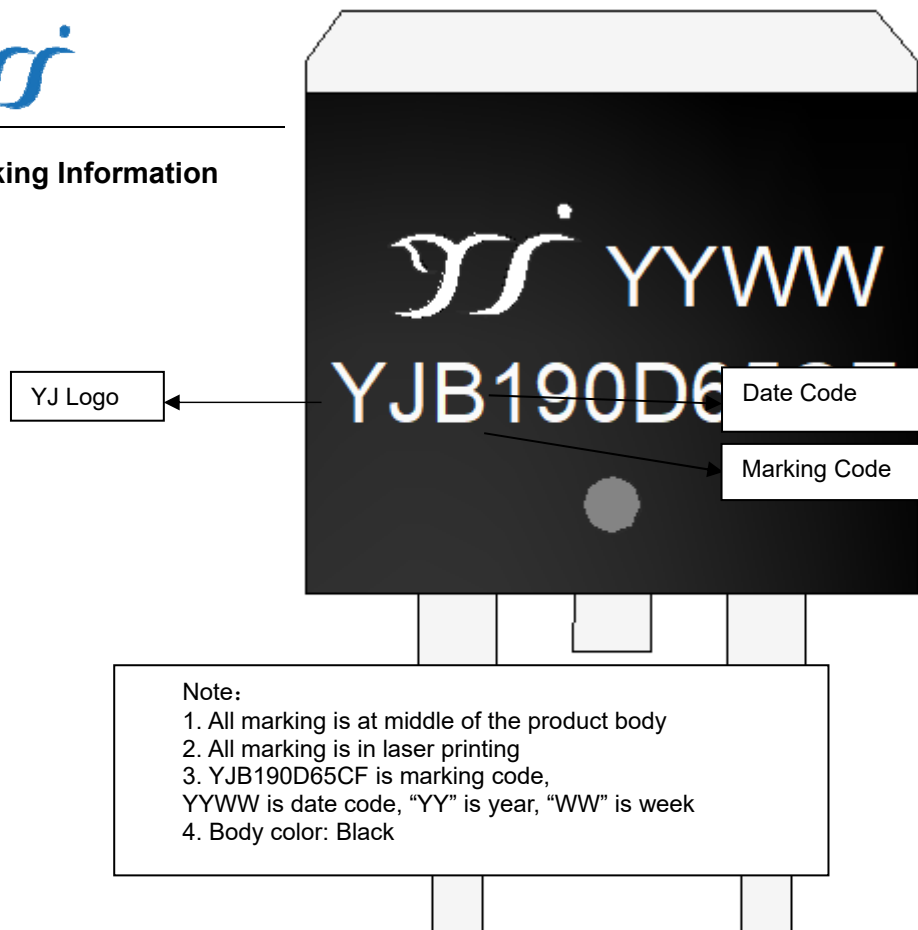
SYMBOL	DIMENSIONS			
	INCHES		MILLIMETER	
	MIN.	MAX.	MIN.	MAX.
A1	0.000	0.010	0.000	0.254
A2	0.160	0.190	4.064	4.826
b	0.020	0.039	0.508	0.991
b2	0.045	0.070	1.143	1.778
c	0.015	0.029	0.381	0.737
c2	0.045	0.065	1.143	1.651
D	0.380	0.420	9.652	10.668
D1	0.245	---	6.223	---
E	0.575	0.625	14.605	15.875
E1	0.330	0.380	8.382	9.652
E2	0.270	---	6.858	---
e	0.200BSC		5.08BSC	
L	0.070	0.110	1.778	2.794
L1	---	0.066	---	1.676
L2	---	0.070	---	1.778
L3	0.188	0.208	4.780	5.280
θ	0°	8°	0°	8°

NOTE:

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
- 3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.



■ Marking Information





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